# Coating Thickness Measurement Instruments FMP10, FMP20, FMP30 and FMP40. The Flexible Solution for Your Measurement Applications

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Coating Thickness 📊 Material Analysis 🗵 Microhardness 🔍 Material Testing

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# State-of-the-Art Coating Thickness Measurement

The Fischer proven portable instruments with exchangeable probes allows for non-destructive and highly precise measurements of coatings. Whether for quality control in a manufacturing process or incoming inspection of random samples or complete batches, these user-friendly and flexible instruments will meet your requirements.

Select the appropriate instrument from the FMP family and combine it with one of our high-precision measurement probes.



Quality monitoring on engine pistons immediately after the manufacturing process using the FTA3.3H probe

## **Special features**

- Fast and non-destructive measurement on steel or iron (F) and non-ferrous metals (NF)
- Automatic probe and substrate recognition
- Large color display
- Supports measurements according to IMO PSPC, SSPC-PA2, QUALANOD and QUALICOAT
- USB interface, Bluetooth or COM interface as option
- Over 70 various high-precision probes for even the most sophisticated measurement applications



Measurements using the internal probe FAI 3.3-150



Paint coating thickness measurement using the dual probe FD13H

Probes	DELTASCOPE®	DUALSCOPE®	ISOSCOPE®	Storable meas. applications	Statistics, evaluation	Measurement strategies
exchangeable	0.46	3.63		1	<ul> <li>Display of the most significant statistical values (number of measurements, mean value, standard deviation, min, max, range)</li> </ul>	<ul> <li>Single reading acquisition</li> <li>Free-running display</li> </ul>
	DELTASCOPE® FMP10	DUALSCOPE® FMP20	ISOSCOPE® FMP10			
	0.62         Image: State of the state	Image: State of the state	Image: Constraint of the second se	up to 100	<ul> <li>Display of the most significant statistical values (number of measurements, mean value, standard deviation, min, max, range) and specific values</li> <li>Tolerance monitoring</li> <li>Graphical evaluation</li> </ul>	<ul> <li>Single reading acquisition</li> <li>Free-running display</li> <li>Area measurement</li> <li>Multiple measurements</li> <li>Automatic measurement</li> <li>Matrix mode</li> <li>IMO PSPC</li> <li>SSPC-PA2</li> <li>QUALANOD</li> <li>QUALICOAT</li> </ul>
Measurement method	Magnetic induction method (DIN EN ISO 2178, ASTM D7091)	Eddy current method <b>and</b> magnetic induction method (DIN EN ISO 2360 and 2178)	Eddy current method (DIN EN ISO 2360, ASTM D7091)			

# DELTASCOPE® FMP10 and FMP30

For the measurement on ferrous substrates (F), e.g. paint, lacquer, powder coating, chrome, copper, zinc, as well as enamel or plastic coatings on steel and iron.

# ISOSCOPE® FMP10 and FMP30

For the measurement of paint, powder coating, lacquer or plastic coatings on non-ferromagnetic metal substrates (NF) or anodic coatings on aluminum or electrically conducting coatings on non-conducting carrier materials.

# DUALSCOPE® FMP20 and FMP40

Due to automatic substrate material recognition and the integration of both measurement methods, these universal instruments are capable of measuring coatings on steel and iron (F) and on non-ferromagnetic metals (NF). Duplex coatings (lacquer/zinc) on steel can be measured simultaneously with the values of the lacquer and zinc coatings displayed individually.



DUALSCOPE® FMP40 using the duplex probe FDX13H

Coating Thickness Measurement Instruments DELTASCOPE<sup>®</sup> FMP10, ISOSCOPE<sup>®</sup> FMP10, DUALSCOPE<sup>®</sup> FMP20





DELTASCOPE® FMP10 using the probe FGAB1.3

The portable FMP10 and FMP20 represent precise measurement technology and are ideal for samples and control measurement. These user-friendly and sturdy instruments can be adapted to all requirements of coating thickness measurement using exchangeable measuring probes. The most significant statistical values are displayed and can be stored together with the calibration in the instrument, ensuring quick and reliable operation.

# Features of the FMP10 and FMP20

# Instrument features

- For magnetic induction and eddy current probes
- Automatic substrate and probe recognition
- Easy-to-use with intuitive menu
- Large contrast-rich color display
- Memory for up to 1,000 readings
- USB interface
- Instant measurement upon probe placement
- Audible signal with measurement acquisition
- Easy adaptation to the shape of the specimen through a zero-point correction (normalization)
- Easy to perform corrective calibration (verification of accuracy)
- Sliding cover to protect keys against unintentional operation
- Various language settings
- Units of measurement can be switched between µm and mils

## Measurement strategies and evaluation

- Single reading acquisition
- Measurements with the "free-running display" mode for continuous scanning of surfaces
- Statistical display of significant values such as mean value, standard deviation, min, max, range



DUALSCOPE® FMP20 using the probe FTD3.3



ISOSCOPE® FMP10 using the probe FTA3.3-Cu

# Coating Thickness Measurement Instruments DELTASCOPE® FMP30, ISOSCOPE® FMP30, DUALSCOPE® FMP40

# Additional features of the FMP30 and FMP40

# Instrument features

- External key-triggered measurement acquisition, e.g. in hollow cylinders with small diameters
- Audible and visual warning when tolerance limits are exceeded
- Option Bluetooth or COM additional available to the default USB interface

# Measurement application memory

- Application memory for up to 100 measuring applications incl. calibration (adjustment settings)
- Memory for up to 20,000 readings
- Allocation of readings into up to 4,000 blocks
- Date and time stamp for blocks
- Application linking mode: Common normalization/ calibration of measuring applications
- Validation of the corrective calibration by test measurements on standards

# Measurement strategies and evaluation

- Stored specifications for measurements according to IMO PSPC, SSPC-PA2, QUALANOD and QUALICOAT
- Capability to enable matrix measurement mode for correlated multi-point measurements
- Averaging of measurement data: Only the mean value of several readings will be stored
- Measurement acquisition through area measurement: Single readings are captured until probe lift-off and averaged
- Outlier rejection settings for automatic elimination of erroneous measurements
- Free-running display with additional presentation of the reading as an analog bar between the tolerance limits
- Statistics display of the most significant values in the block and final results. Output of variance-analytical values
- Graphical measurement display as a histogram
- Capability of entering process tolerance limits and computation of the associated process capability indices c<sub>p</sub> and c<sub>pk</sub>



ISOSCOPE® FMP30 using probe FTA3.3H



DELTASCOPE® FMP30 using dual-tip probe V7FKB4



DUALSCOPE® FMP40 using probe FD13H



The FMP30 and FMP40 instruments feature additional more memory for numerous customer-specific measuring applications as well as extensive graphical and statistical evaluations. Tolerance limits can be entered into the calibratable measuring applications and the production process can be analyzed statistically.



DUALSCOPE® FMP40 using the probe FGAB1.3 and support stand V12 BASE – measuring parts with position accuracy

# Versatile Probes Program and Ordering Information

## Probe program

The extensive selection of FISCHER probes is as versatile as the measurement applications of our customers. A probe needs specific properties for each field of application for achieving best results with a high accuracy. Over 70 probes can be connected to the instrument family FMP10 to FMP40. Thus, you can solve even the most sophisticated measurement tasks.

# Probe selection based on several criteria

- Material combination of coating and substrate material
- Thickness of coating and substrate material
- Dimension of the measurement area
- Shape of the specimen
- Surface condition of the measurement area

# Call us

We can help you choose the right probe for your specific application.

# Ordering information Order no. DELTASCOPE® FMP10 605-021 ISOSCOPE® FMP10 605-027 DUALSCOPE® FMP20 605-023 DELTASCOPE® FMP30 605-022 ISOSCOPE® FMP30 605-028 DUALSCOPE® FMP40 605-024

## Standard content of instrument shipment

- Instrument
- Short form operator's manual, print version
- Support CD with evaluation and archiving software DataCenter, USB drivers and operator's manual
- Carrying strap FMP
- USB interface cable FMP/ PC
- Battery set FMP (Alkaline)
- Carrying case FMP only for FMP30 and FMP40 instruments

#### **Optional accessories** Order no. 604-148 Carrying case FMP Adapter E-probe/F-socket 604-214 AC adapter FMP30 and FMP40 604-290 Rechargeable battery set FMP (NiMH) 604-295 Charger AA/Mignon 604-335 Measurement stand V12 BASE 604-420 Measurement stand V12 MOT 604-374 (motor-driven) Bluetooth Module for wireless 604-480 data transfer COM Module FMP30/FMP40, 604-500 RS232 interface Interface connection set for COM Module 602-341 Protective cover for instrument 604-149

# **FISCHER Services**

## Service worldwide

FISCHER has established a tightly-linked global network of service partners with highly qualified staff. Offering fast help, repairs and the availability of leasing and rental units. FISCHER supports you in every respect concerning your instruments and their use.

## Calibration and certification

Fischer Technology performs a full inspection and calibration of all instruments and probes prior to delivery to the customer. A broad assortment of calibration standards is available and a Certification certificate is issued with every instrument and calibration standard.



# **Application laboratories**

More and more, demanding applications require highly qualified application advice. FISCHER addresses this need with its application laboratories located around the world (Germany, Switzerland, China, USA).



Measuring on a customer's specimen in a FISCHER application laboratory

## User on-site training

We offer on-site training for your employees and take into account your individual requirements and requests.



User training for the DUALSCOPE® FMP100 on-site at the customer's

## Seminars

Because we want you to receive maximum benefit from our products, FISCHER's experts are happy to share their application know-how. The seminars not only teach metrological basics but also hands-on experience in small groups to put the theory into practice.



A FISCHER seminar teaches metrological basics and practical knowledge in small groups

# Fischer Worldwide

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